

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination SAKAMA ET AL.	
		Examiner Johannes P. Mondt	Art Unit 3663	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Wörhoff et al, "Silicon oxynitride in integrated optics", in "Lasers and Electro-Optics Society Annual Meeting, 1998, LEOS'98, IEEE, Publication Date: 1-4 December 1998, Volume 2, pages 370-371, Orlando, FL (USA).
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